Application/Control No. Applicant(s)/Patent Under Reexamination 10/766,014 HAIDNER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2877 Andrew Hwa S. Lee **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0114150	06-2004	Wegmann et al.	356/491
	В	US-			
	С	US-			
	D	US-			
	E	US-			···
	F	US-			
	G	US-			· · · · · · · · · · · · · · · · · · ·
	Н	US-			
	1	US-			
	J	US-			
	к	US- 。			<u> </u>
	L	US-			
	М	US-	<u></u>		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	٠				
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
	. .		
	w	•	
	×	(

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.